C om positional D ependence of Form ation Energies of Substitutional and Interstitial M n in Partially C om pensated (G a, M n)As

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W e use the density-functional theory to calculate the total energy of m ixed crystals (G a,M n)As with a sm all concentration of various donors. We nd that the form ation energy of M n depends strongly on the partial concentrations of M n in the substitutional and interstitial positions, and on the concentration of other dopants. The composition dependence of the form ation energies represents an elective feedback mechanism, resulting in the self-compensation property of (G a,M n)As. We show that the partial concentrations of both substitutional and interstitial M n increase proportionally to the total concentration of M n.

PACS numbers: 71.15 Ap, 71.20 Nr, 71.55 Eq, 75.50 Pp

I. IN TRODUCTION

The dilute m agnetic sem iconductors (DMS), such as G aAs doped with a large am ount of Mn, represent an important class ofm ixed crystals with promising applications in spin electronics [1]. The ferrom agnetic behavior of these m aterials is mediated by the holes in the valence band [2, 3]. It is sensitive to the number of free carriers and to the level of charge compensation. Mn atoms substituted in the cation sublattice of a III-V sem iconductor are acceptors and produce one hole each. It is known, how ever, that som e Mn atoms occupy the interstitial positions and act as double donors [4, 5, 6, 7, 8].

The interplay between the substitutional and interstitial incorporation of M n into the G aA s lattice has, together with co{doping (cf. Ref. [9]), a crucial e ect on the physical properties of the m ixed crystal (G a,M n)A s. A system atic study of form ation energies of the substitutional (M n_{G a}) and interstitial (M n_{int}) m anganese can help to understand it on a m icroscopic level.

In the case of weak doping sm all changes in the inpurity concentration can easily move the Ferm i energy E_F across the band gap with a negligible in uence on the density of states. That is why the dependence of the form ation energies on the number of electrically active in purities is usually represented by their dependence on E_F . The Ferm i-level dependent form ation energy is obtained by adding (or subtracting) E_F to the form ation energy calculated for a particular electronic con guration [10]. In the case of a strongly doped and m ixed crystals, how ever, the redistribution of the electron states in the valence band due to the in purities cannot be neglected and the density-of-statese ectm odi es the sim ple Ferm ilevel rule for the form ation energies.

That is why the knowledge of the formation energy as a function of the impurity concentrations is necessary in the DMS. To calculate the energy needed to incorporate Mn and other impurities in a mixed crystal, we use the trick relating them to the compositiondependent total energy of the mixed crystal [11]. This quantity is obtained within the density {functional theory for a series of (G a,M n)As m ixed crystals with various content of M n in substitutional and interstitial positions, and with variable concentration of the compensating donors. The use of the coherent potential approxim ation (CPA) combined with the tight{binding linearized{ mu n{tin{orbitalmethod (TB-LMTO) [12] m akes possible to change the chem ical composition continuously. The lattice relaxation around the impurities and the clustering of the M n atom s are om itted within the CPA. For sim plicity, we consider only the interstitial M n atom s in the T (A s₄) position; the energy of the other T (G a₄) position is alm ost the same [13]. The form ation energies are obtained as the rst derivatives of the total energy with respect to the corresponding partial concentration [11].

A ssum ing a quasi{equilibrium deposition conditions, characterized by an elective growth temperature, we use the calculated formation energies to estimate the numbers of M n_{G a} and M n_{int} in (G a,M n)Asmixed crystal. We also present a simple way to determ ine the partial concentrations directly from the composition dependence of the formation energies, without solving therm odynamical balance equations.

II. COM POSITION DEPENDENCE OF THE FORM ATION ENERGIES

We consider an impure or mixed crystal with several kinds of impurities I_1 , I_2 , etc.. The total energy of the mixed crystalW ($x_1; x_2; ::$), normalized to a unit cell, depends on their molar concentration x_i . As we showed recently [11], the formation energy E_i of an impurity I_i can be obtained by dimensional ($x_1; x_2; ::$) with respect to x_i , namely

$$E_{i}(\mathbf{x}_{1};\mathbf{x}_{2};::) = \frac{(W_{i}(\mathbf{x}_{1};\mathbf{x}_{2};::))}{(W_{i}(\mathbf{x}_{1})} = E^{atom}(\mathbf{I}_{i}) + E^{atom}(host);$$
(1)

The last two terms in Eq. (1) are the total energies of an atom I_i and of the corresponding atom of the host, which

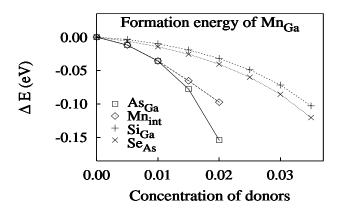


Figure 1: Relative form ation energy $\,E\,$ of the substitutional M $n_{G\,a}\,$ in G $a_{0:96}M\,n_{0:04}A\,s$ as a function of the concentration of various donors.

has been replaced by I_i .

G enerally, the de nition of the form ation energy is not unique and depends on the way in which the atom ic energies E^{atom} (host) and E^{atom} (I_i) in Eq. (1) are obtained. We use the energies of neutral atom s in their ground state. It is in portant to notice, how ever, that the additional constant in Eq. (1) does not depend on the actual chem icalcom position of the material. It is not in portant for the concentration {dependent trends we have in m ind.

That is why we consider now only the relative form ation energies E $_{\rm i}$, obtained from their actual values E $_{\rm i}$ by subtracting the corresponding form ation energy calculated for the reference material. As a reference, we take G $a_{0:96}$ M $n_{0:04}$ A swith allM n atom s in regular M $n_{G\,a}$ positions.

The composition dependence of the form ation energies E_i is characterized by the coe-cients of the linear expansion around the reference point,

$$K_{ij} \quad \frac{\partial E_{i}}{\partial x_{j}} = \frac{\partial^{2} W(x_{1}; x_{2}; ::)}{\partial x_{i} \partial x_{j}}: \qquad (2)$$

The correlation energies K $_{\rm ij}$ [11] form a symmetric matrix. K $_{\rm ij}$ < 0 m eans that the presence of the defects $I_{\rm i}$ supports form ation of $I_{\rm j}$ and vice versa; K $_{\rm ij}$ > 0 indicates the opposite tendency.

The dependence of the relative form ation energy E of the M $n_{G\,a}$ on the concentration of various donors is sum marized in Fig. 1. We considered four representative examples. Se_{A\,s} and Si_{G\,a} are typical donors with one extra electron, situated at anion and cation sublattice, respectively. The other two cases, i.e., As antisite defect A $s_{G\,a}$ and M n_{int} are the most important native defects in (G a,M n)As, both acting as double donors. Fig. 1 shows that the form ation energy of M $n_{G\,a}$ decreases in the presence of an increasing number of donors. The curves are grouped into pairs according to the charge state of the donors, with only a minor in uence of the particular chemical origin of the defect. The dependence is alm ost linear for low concentrations and the slope of

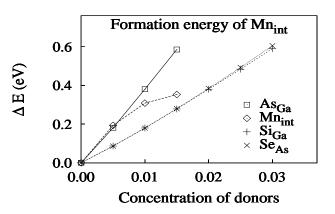


Figure 2: Relative form ation energy E of the interstitial M n in G $a_{0:96}$ M $n_{0:04}$ A s as a function of the concentration of various donors.

the function is roughly proportional to the charge state of the donor. This all indicates that the variations of the form ation energy of M $n_{G\,a}$ are mostly determ ined by the Ferm i{ level e ect, not by the redistribution of the density of states induced by the other defects.

A nalogous results are obtained for the form ation energy of the interstitial M n in the T (As₄) position, as shown in Fig. 2. In this case, however, the form ation energy of M n_{int} increases with increasing number of the donors. It is important to notice that the steep increase of the form ation energy represents a feedback m echanism limiting e ciently the number of M n int. The same is valid also for the form ation energy of the As antisite defect.

Fig. 3 shows the form ation energies of the two native defects, i.e. A $_{\rm S_{G}\,a}$ and M $_{\rm int}$, in the m ixed crystal with varying number of the substitutional M n in the G a sublattice. Notice that both relative quantities, being pinned to zero for the reference m aterial with 4 $\%\,$ of M $n_{\rm G\,a}$, are alm ost identical. In both cases, the form ation energy is a decreasing function, indicating an increasing probability of form ation of these defects in m aterials with a higher concentration of M n.

This self-compensation tendency is a very important mechanism controlling the basic physical properties of (G a,M n)As mixed crystals. It is the reason for the observed low doping e ciency of M n in G aAs [14]. The increasing number of both As_{G a} and M n_{int} also explains the expansion of the lattice of (G a,M n)As with an increasing concentration of M n [15].

III. DYNAM ICAL EQUILIBRIUM BETW EEN M $n_{G\,a}$ AND M $n_{\rm int}$

In this Section, we use the calculated formation energies to simulate the incorporation of M n into the (G a, M n) A sm ixed crystal. We assume that the probabilities that an M n atom occupies either substitutional or

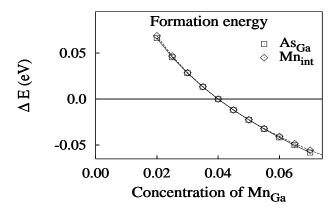


Figure 3: The form ation energy of the interstitial M n and A s antisite defect in G a₁ $_{\rm X}$ M n_xA s as a function of the concentration x of M n atom s substituted in the G a sublattice. The form ation energies are referred to the values corresponding to G a_{0.96} M n_{0.04} A s

interstitial position are related to the corresponding formation energies $E_{\rm S}$ and $E_{\rm I}$ also in the non-equilibrium epitaxial growth. As a simplest approximation, we characterize the deposition condition with some elective temperature $T_{\rm eff}$ and use the corresponding Boltzm ann weighting factors.

To this purpose, the absolute form ation energies of M n in the two crystallographic positions, i.e. M n_{Ga} and M n_{int} , are required. They are obtained for the reference system G $a_{0:96}$ M $n_{0:04}$ As including the additive terms from Eq. (1). For the epitaxial growth, it is reasonable to use E ^{atom} calculated for isolated atoms as stated above. A linear interpolation for the dependence of E _S and E _I on the corresponding partial concentrations x_S and x_I is used:

$$E_{S}(x_{S};x_{I}) = E_{S}^{\circ} + S_{S}x_{S} + S_{I}x_{I}$$
(3)

$$E_{I}(\mathbf{x}_{\mathrm{S}};\mathbf{x}_{\mathrm{I}}) = E_{\mathrm{I}}^{\circ} + I_{\mathrm{I}}\mathbf{x}_{\mathrm{S}} + I_{\mathrm{I}}\mathbf{x}_{\mathrm{I}}$$
(4)

with $E_{S}^{\circ} = 0.31 \text{ eV}$, $E_{I}^{\circ} = 0.42 \text{ eV}$, $_{SS} = 0.17 \text{ eV}$, $_{SI} = _{SI} = 6.03 \text{ eV}$, and $_{II} = 10.33 \text{ eV}$.

The composition dependent formation energies, Eqs. (3-4), de ne the thermodynamic probabilities p_S and p_I that extra M n atom s occupy substitutional or interstitial position in the mixed crystal with a given composition. They are

$$p_{S;I} = \frac{\exp(E_{S;I} = kT_{eff})}{\exp(E_{S} = kT_{eff}) + \exp(E_{I} = kT_{eff})}:$$
 (5)

On the other hand, these probabilities determ ine the number of M n atom s that substitute for G a or occupy the interstitial positions. The resulting changes of the partial concentrations x_S and x_I due to the variation dx of the total concentration x of M n are

$$dx_{\rm S} = p_{\rm S} dx; dx_{\rm I} = p_{\rm I} dx; \qquad (6)$$

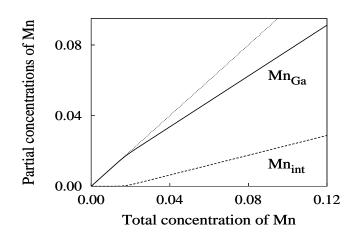


Figure 4: The partial concentrations of M $n_{G\,a}$ (solid) and M $n_{\rm int}$ (dashed) as a function of the total concentration of M n in (G a,M n)As for $T_{\rm ef\,f}$ = 500 K. The in uence of other dopants is not considered.

and the dependence of x_S and x_I on x can be obtained by the integration of Eq. (6).

Fig. 4 shows the solution of Eq.(6) for T_{eff} = 500 K. For the lowest concentrations (x < 0.015), M n atom s occupy preferentially the substitutional positions which have lower formation energy (cf. Eqs.(3,4)). For higher concentration of M n, however, the di erence of $E_{I}(x_{S};x_{I}) = E_{S}(x_{S};x_{I})$ decreases and approaches zero. From this point, both positions can be occupied with a com parable probability, and the partial concentrations of both $M n_{Ga}$ and $M n_{int}$ increase proportionally to x. Any deviation from the situation with $E_s = E_I$ changes the form ation energies of M n_{Ga} and M n_{int} in such a way that the dynam ical equilibrium is restored. As a result, the high-concentration regime with co-existing M n_{G a} and M n_{int} is stabilized. This nding does not depend much on T_{eff} over a wide tem perature range. W e can conclude that the partial concentrations of M n are simply given by the equation

$$E_{S}(x_{S};x_{I}) = E_{I}(x_{S};x_{I});$$
(7)

together with the condition $x_S + x_I = x$. Combining Eqs. (3,4) with (7) we nd that the proportion of M n_{Ga} and M n_{int} atom s is roughly 3:1, in a very good agreem ent with both experiment [4] and theoretical expectations [6, 15] for the as{grow n m aterials.

It is important to point out that according to Eqs. (3,4,7) both M n_{G a} and M n_{int} atom s rem ain m etastable with the activation energy 0.3 eV in the whole concentration range shown in Fig. 4. The formation energies used in our dynam ical{equilibrium approach control the preferential incorporation of M n atom s during the grow th. The annealing process, on the other hand, depends on the barriers preventing the M n atom s to leave their m etastable positions. The barriers are lower for M n_{int} than for M n_{G a} position [16], so that the post{ grow th treatment can substantially reduce the num ber of

the interstitial M n atom s without a remarkable change of the num ber of M $n_{G\,a}\,.$

IV. SUMMARY

We have shown that the formation energies of M n in either substitutional or interstitial position depend strongly on the partial concentrations of both M $n_{G\,a}$ and M $n_{\rm int}$, and also on the number of compensating donors. A lso the formation energy of A $s_{G\,a}$ antisite, the main native defect in (G a,M n)As, is very sensitive to the concentration of M n.

The composition dependence of the formation energies represent a feedback mechanism which de nes a dynamical equilibrium between M n_{Ga} , M n_{int} , and other de-

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fects and in purities during the growth. In particular, we found that at higher M n concentrations the number of both M $n_{G\,a}$ and M $n_{\rm int}$ increases proportionally to the total concentration of M n in the as{grown (G a,M n)As m ixed crystal.

In addition, the concentration dependence of the formation energy of the A $_{S_{G\,a}}$ antisite defects indicates that an increasing number of these donors also participate in the compensation of the regular M $n_{G\,a}$ acceptors for higher M n concentrations.

A cknow ledgm ent This work has been done within the project AVO Z1-010-914 of the AS CR. The nancial support was provided by the Academy of Sciences of the C zech Republic (G rant No. A 1010214) and by the G rant A gency of the C zech Republic (202/04/583).

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